Notice of References Cited Application/Control No. 10/781,219 Examiner TAN TRINH Applicant(s)/Patent Under Reexamination BACKES ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,907,229	06-2005	Shpak, Eran	455/69
*	В	US-7,054,640	05-2006	Bing et al.	455/452.1
*	С	US-2002/0193133	12-2002	Shibutani, Akira	455/522
*	D	US-2004/0132458	07-2004	Bing et al.	455/452.2
*	Ε	US-2004/0022219	02-2004	Mangold et al.	370/336
*	F	US-2003/0100328	05-2003	Klein et al.	455/522
*	G	US-2004/0037247	02-2004	Ngo, Chiu Y.	370/332
*	Η	US-2002/0090966	07-2002	Hansen et al.	455/522
*	_	US-2004/0038697	02-2004	Attar et al.	455/522
*	7	US-5,724,346	03-1998	Kobayashi et al.	370/329
*	К	US-2004/0202141	10-2004	Sinivaara et al.	370/338
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.